

| Search Notes | Application/Control No. | Applicant(s)/Patent under Reexamination |
|--------------|-------------------------|-----------------------------------------|
| | 10/671,861 | LEE ET AL. |
| Examiner | Art Unit | |
| Alex Liew | 2624 | |

| INTERFERENCE SEARCHED | | | |
|------------------------------|----------|------|----------|
| Class | Subclass | Date | Examiner |
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